## Notice of References Cited Application/Control No. 10/024,142 Examiner Quoc A. Tran Applicant(s)/Patent Under Reexamination MORGAN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0049788 A1	04-2002	Lipkin et al.	707/513
	В	US-2003/0074636 A1	04-2003	Manepalli, Harish	715/513
	С	US-2002/0003547 A1	01-2002	Wang et al.	345/727
	D	US-2002/0078168 A1	06-2002	Christfort et al.	709/217
	E	US-2003/0018694 A1	01-2003	Chen et al.	709/200
	F	US-6,583,800 B1	06-2003	Ridgley et al.	345/854
	G	US-6,650,433 B1	11-2003	Keane et al.	358/1.15
	Н	US-2003/0140308 A1	07-2003	Murthy et al.	715/500
	-	US-6,353,483 B1	03-2002	Laverty et al.	358/1.15
	J	US-6,424,979 B1	07-2002	Livingston et al.	715/511
	к	US-			
	L	US-			
$\sqcap$	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	60/328819
	٧	60/326052
	w	
	x	

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